MOSFETs Silicon P-/N-Channel MOS (U-MOSVI/U-MOSVI-H)

# **TPC8408**

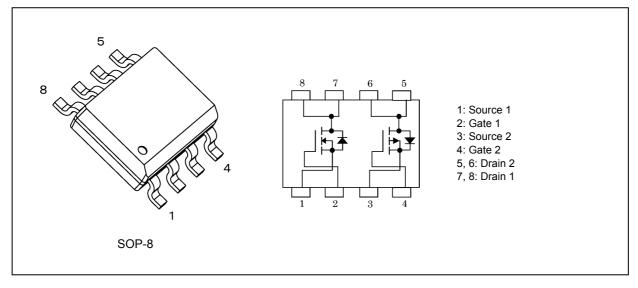
### 1. Applications

- Mobile Equipments
- Motor Drivers

### 2. Features

- (1) Small footprint due to a small and thin package
- (2) High speed switching
- $\begin{array}{ll} \text{(3)} & \text{Low drain-source on-resistance} \\ & \text{P-channel } R_{\text{DS(ON)}} = 33 \text{ m}\Omega \text{ (typ.) } (\text{V}_{\text{GS}} = \text{-}10 \text{ V}), \\ & \text{N-channel } R_{\text{DS(ON)}} = 24 \text{ m}\Omega \text{ (typ.) } (\text{V}_{\text{GS}} = 10 \text{ V}) \end{array}$
- (4) Low leakage current P-channel  $I_{DSS} = -10 \ \mu A \ (max) \ (V_{DS} = -40 \ V),$ N-channel  $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 40 \ V)$
- (5) Enhancement mode P-channel V<sub>th</sub> = -0.8 to -2.0 V (V<sub>DS</sub> = -10 V, I<sub>D</sub> = -0.1 mA), N-channel V<sub>th</sub> = 1.3 to 2.3 V (V<sub>DS</sub> = 10 V, I<sub>D</sub> = 0.1 mA)

### 3. Packaging and Internal Circuit



### 4. Absolute Maximum Ratings (Note) ( $T_a = 25^{\circ}C$ unless otherwise specified)

| Characteristics                        | P/N        | Symbol             | Rating | Unit              |            |    |
|--|------------|--------------------|--------|-------------------|------------|----|
| Drain-source voltage                   | P-ch       | V <sub>DSS</sub>   | -40    | V                 |            |    |
|  |            |                    | N-ch   |                   | 40         |    |
| Gate-source voltage                    |            |                    | P-ch   | V <sub>GSS</sub>  | ±20        |    |
|  |            |                    | N-ch   |                   | ±20        |    |
| Drain current (DC)                     |            | (Note 1)           | P-ch   | I <sub>D</sub>    | -5.3       | А  |
|  |            |                    | N-ch   |                   | 6.1        |    |
| Drain current (pulsed)                 |            | (Note 1)           | P-ch   | I <sub>DP</sub>   | -21.2      | A  |
|  |            |                    | N-ch   |                   | 24.4       |    |
| Power dissipation (single operation)   | (t = 10 s) | (Note 2), (Note 4) | P-ch   | P <sub>D(1)</sub> | 1.5        | w  |
|  |            |                    | N-ch   |                   | 1.5        |    |
| Power dissipation (per device for dual | (t = 10 s) | (Note 2), (Note 5) | P-ch   | P <sub>D(2)</sub> | 1.1        | W  |
| operation)                             |            |                    | N-ch   |                   | 1.1        |    |
| Power dissipation (single operation)   | (t = 10 s) | (Note 3), (Note 4) | P-ch   | P <sub>D(1)</sub> | 0.75       | W  |
|  |            |                    | N-ch   |                   | 0.75       |    |
| Power dissipation (per device for dual | (t = 10 s) | (Note 3), (Note 5) | P-ch   | P <sub>D(2)</sub> | 0.45       | W  |
| operation)                             |            |                    | N-ch   |                   | 0.45       |    |
| Single-pulse avalanche energy          |            | (Note 6)           | P-ch   | E <sub>AS</sub>   | 18         | mJ |
|  |            |                    | N-ch   |                   | 24         |    |
| Avalanche current                      |            |                    | P-ch   | I <sub>AR</sub>   | -5.3       | А  |
|  |            |                    | N-ch   |                   | 6.1        |    |
| Channel temperature                    |            |                    | P-ch   | T <sub>ch</sub>   | 150        | °C |
|  |            |                    | N-ch   |                   | 150        |    |
| Storage temperature                    |            |                    | P-ch   | T <sub>stg</sub>  | -55 to 150 | °C |
|  |            |                    | N-ch   | 1                 | -55 to 150 | 1  |

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### 5. Thermal Characteristics

| Characteristics   | Symbol     | Max                | Unit                     |      |      |
|---|------------|--------------------|--------------------------|------|------|
| Channel-to-ambient thermal resistance (single operation)              | (t = 10 s) | (Note 2), (Note 4) | R <sub>th(ch-a)(1)</sub> | 83.3 | °C/W |
| Channel-to-ambient thermal resistance (per device for dual operation) | (t = 10 s) | (Note 2), (Note 5) | R <sub>th(ch-a)(2)</sub> | 113  |      |
| Channel-to-ambient thermal resistance (single operation)              | (t = 10 s) | (Note 3), (Note 4) | R <sub>th(ch-a)(1)</sub> | 166  |      |
| Channel-to-ambient thermal resistance (per device for dual operation) | (t = 10 s) | (Note 3), (Note 5) | R <sub>th(ch-a)(2)</sub> | 277  |      |

Note 1: Ensure that the channel temperature does not exceed 150°C.

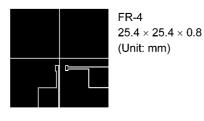
Note 2: Device mounted on a glass-epoxy board (a), Figure 5.1

Note 3: Device mounted on a glass-epoxy board (b), Figure 5.2

Note 4: Power dissipation and thermal resistance values per device with the other device being off (During single operation, power is supplied to only one of the two devices.)

Note 5: Power dissipation and thermal resistance values per device for dual operation (During dual operation, power is evenly supplied to both devices.)

Note 6: P channel: V<sub>DD</sub> = -32 V, T<sub>ch</sub> = 25°C (initial), L = 0.5 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = -5.3 A N channel: V<sub>DD</sub> = 32 V, T<sub>ch</sub> = 25°C (initial), L = 0.5 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AR</sub> = 6.1 A



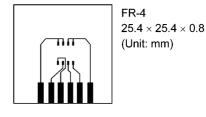


Fig. 5.1 Device Mounted on a Glass-Epoxy Board (a)

Fig. 5.2 Device Mounted on a Glass-Epoxy Board (b)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.

### 6. Electrical Characteristics ( $T_a = 25^{\circ}C$ unless otherwise specified)

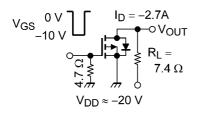
#### 6.1. Static Characteristics

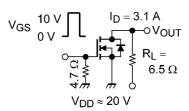
| Characteristics                         | P/N  | Symbol               | Test Condition                                    | Min  | Тур. | Max  | Unit |
|---|------|----------------------|---|------|------|------|------|
| Gate leakage current                    | P-ch | I <sub>GSS</sub>     | $V_{GS}$ = ±20 V, $V_{DS}$ = 0 V                  | _    | _    | ±0.1 | μA   |
|   | N-ch |                      | $V_{GS}$ = ±20 V, $V_{DS}$ = 0 V                  | —    | —    | ±0.1 |      |
| Drain cut-off current                   | P-ch | I <sub>DSS</sub>     | $V_{DS}$ = -40 V, $V_{GS}$ = 0 V                  | —    | —    | -10  | μA   |
|   | N-ch |                      | $V_{DS}$ = 40 V, $V_{GS}$ = 0 V                   | —    | —    | 10   |      |
| Drain-source breakdown voltage          | P-ch | V <sub>(BR)DSS</sub> | I <sub>D</sub> = -10 mA, V <sub>GS</sub> = 0 V    | -40  | _    | _    | V    |
|   | N-ch |                      | I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V     | 40   | —    | —    |      |
| Drain-source breakdown voltage (Note 7) | P-ch | V <sub>(BR)DSX</sub> | $I_{\rm D}$ = -10 mA, $V_{\rm GS}$ = 10 V         | -30  | —    | —    | V    |
|   | N-ch |                      | $I_{D}$ = 10 mA, $V_{GS}$ = -20 V                 | 23   |      | —    |      |
| Gate threshold voltage                  | P-ch | V <sub>th</sub>      | V <sub>DS</sub> = -10 V, I <sub>D</sub> = -0.1 mA | -0.8 | —    | -2.0 | V    |
|   | N-ch |                      | $V_{DS}$ = 10 V, I <sub>D</sub> = 0.1 mA          | 1.3  | _    | 2.3  |      |
| Drain-source on-resistance              | P-ch | R <sub>DS(ON)</sub>  | $V_{GS}$ = -4.5 V, I <sub>D</sub> = -2.7 A        | _    | 41   | 53   | mΩ   |
|   |      |                      | V <sub>GS</sub> = -10 V, I <sub>D</sub> = -2.7 A  | —    | 33   | 43   |      |
|   | N-ch | 1                    | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 3.1 A   | _    | 28   | 36   |      |
|   |      |                      | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.1 A    | _    | 24   | 32   |      |

Note 7: If a reverse bias is applied between gate and source, this device enters V<sub>(BR)DSX</sub> mode. Note that the drainsource breakdown voltage is lowered in this mode.

#### 6.2. Dynamic Characteristics

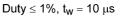
| Characteristics                | P/N  | Symbol           | Test Condition   | Min | Тур. | Max | Unit |
|--------------------------------|------|------------------|--|-----|------|-----|------|
| Input capacitance              | P-ch | C <sub>iss</sub> | V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz | _   | 1105 | _   | pF   |
|                                | N-ch |                  | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz  | _   | 850  | _   |      |
| Reverse transfer capacitance   | P-ch | C <sub>rss</sub> | V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz | _   | 135  | _   | pF   |
|                                | N-ch |                  | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz  | _   | 40   | —   |      |
| Output capacitance             | P-ch | C <sub>oss</sub> | V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz | —   | 165  | —   | pF   |
|                                | N-ch |                  | V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V,<br>f = 1 MHz  | —   | 145  | —   |      |
| Switching time (rise time)     | P-ch | t <sub>r</sub>   | See Figure 6.2.1.  | _   | 8.1  | _   | ns   |
|                                | N-ch |                  | See Figure 6.2.2.  | _   | 2.0  | _   |      |
| Switching time (turn-on time)  | P-ch | t <sub>on</sub>  | See Figure 6.2.1.  | _   | 16   | _   | ns   |
|                                | N-ch |                  | See Figure 6.2.2.  | _   | 7.0  | _   |      |
| Switching time (fall time)     | P-ch | t <sub>f</sub>   | See Figure 6.2.1.  | _   | 33   | _   | ns   |
|                                | N-ch |                  | See Figure 6.2.2.  | _   | 2.3  | _   |      |
| Switching time (turn-off time) | P-ch | t <sub>off</sub> | See Figure 6.2.1.  | _   | 131  | —   | ns   |
|                                | N-ch |                  | See Figure 6.2.2.  | _   | 17   | —   |      |





Duty  $\leq$  1%,  $t_W =$  10  $\mu s$ 

Fig. 6.2.1 Switching Time Test Circuit (P-ch) Fig. 6.2.2 Switching Time Test Circuit (N-ch)



#### 6.3. Gate Charge Characteristics

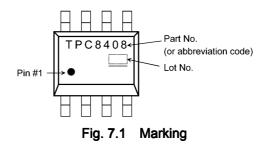
| Characteristics                                 | P/N  | Symbol           | Test Condition   | Min | Тур. | Max | Unit |
|---|------|------------------|--|-----|------|-----|------|
| Total gate charge (gate-source plus gate-drain) | P-ch | Qg               | V <sub>DD</sub> ≈ -32 V, V <sub>GS</sub> = -10 V,<br>I <sub>D</sub> = -5.3 A   | —   | 24   | —   | nC   |
|   | N-ch |                  | $V_{DD} \approx 32 \text{ V}, \text{ V}_{GS} = 10 \text{ V},$<br>$I_D = 6.1 \text{ A}$   | —   | 14   | —   |      |
| Gate-source charge 1                            | P-ch | Q <sub>gs1</sub> | $V_{DD} \approx$ -32 V, $V_{GS}$ = -10 V,<br>I <sub>D</sub> = -5.3 A   | —   | 3.0  | —   | nC   |
|   | N-ch |                  | $\label{eq:VDD} \begin{array}{l} V_{DD} \approx 32 \; V, \; V_{GS} \texttt{=} \; \texttt{10} \; V, \\ I_{D} \texttt{=} \; \texttt{6.1} \; A \end{array}$ | —   | 2.6  | —   |      |
| Gate-drain charge                               | P-ch | Q <sub>gd</sub>  | $V_{DD} \approx$ -32 V, $V_{GS}$ = -10 V,<br>I <sub>D</sub> = -5.3 A   | —   | 5.3  | —   | nC   |
|   | N-ch |                  | $\label{eq:VDD} \begin{array}{l} V_{DD} \approx 32 \; V, \; V_{GS} \texttt{=} \; \texttt{10} \; V, \\ I_{D} \texttt{=} \; \texttt{6.1} \; A \end{array}$ | —   | 2.4  | —   |      |

#### 6.4. Source-Drain Characteristics

| Characteristics       |          | P/N  | Symbol           | Test Condition                                  | Min | Тур. | Max   | Unit |
|-----------------------|----------|------|------------------|---|-----|------|-------|------|
| Reverse drain current | (Note 8) | P-ch | I <sub>DRP</sub> | —   | _   | _    | -21.2 | А    |
| (pulsed)              |          | N-ch |                  |   | _   | _    | 24.4  |      |
| Diode forward voltage |          | P-ch | V <sub>DSF</sub> | I <sub>DR</sub> = -5.3 A, V <sub>GS</sub> = 0 V | _   | _    | 1.2   | V    |
|                       |          | N-ch |                  | I <sub>DR</sub> = 6.1 A, V <sub>GS</sub> = 0 V  |     | _    | -1.2  |      |

Note 8: Ensure that the channel temperature does not exceed 150°C.

#### 7. Marking (Note)



Note: A line under a Lot No. identifies the indication of product Labels.

Not underlined: [[Pb]]/INCLUDES > MCV

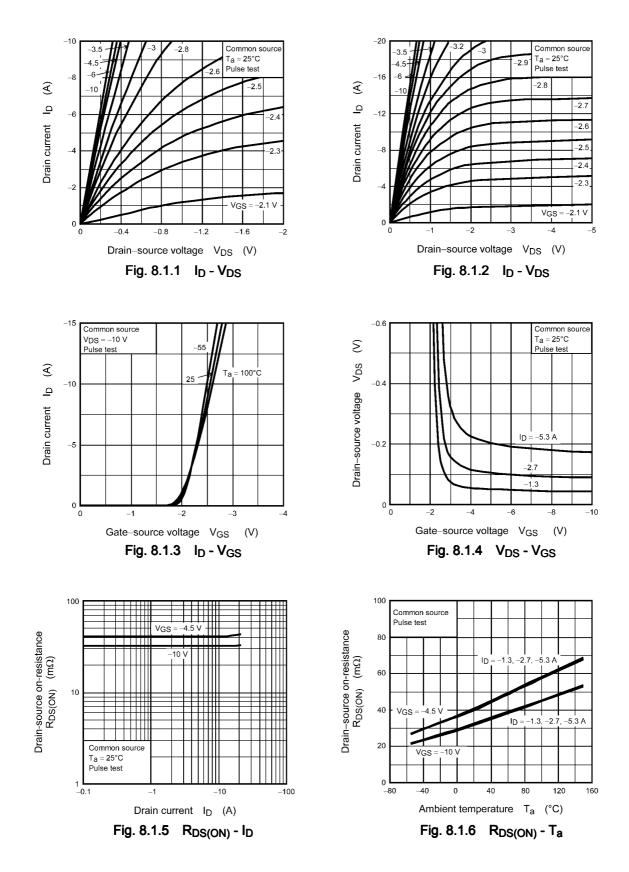
Underlined: [[G]]/RoHS COMPATIBLE or [[G]]/RoHS [[Pb]]

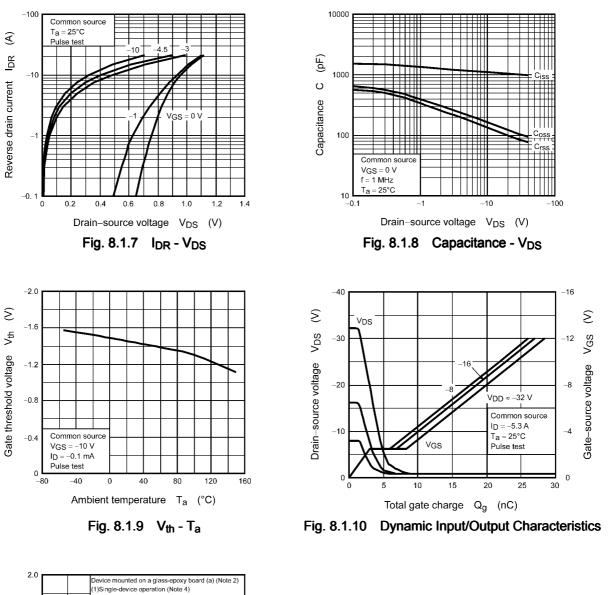
Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product.

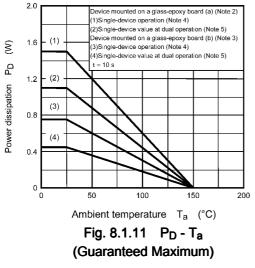
The RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

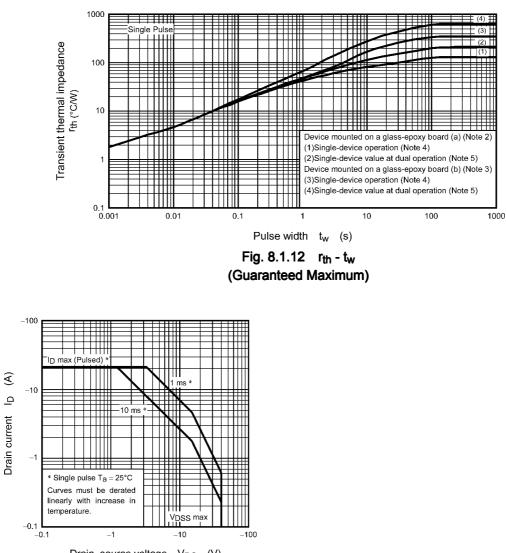
8. Characteristics Curves (Note)

### 8.1. P-Channel MOSFET







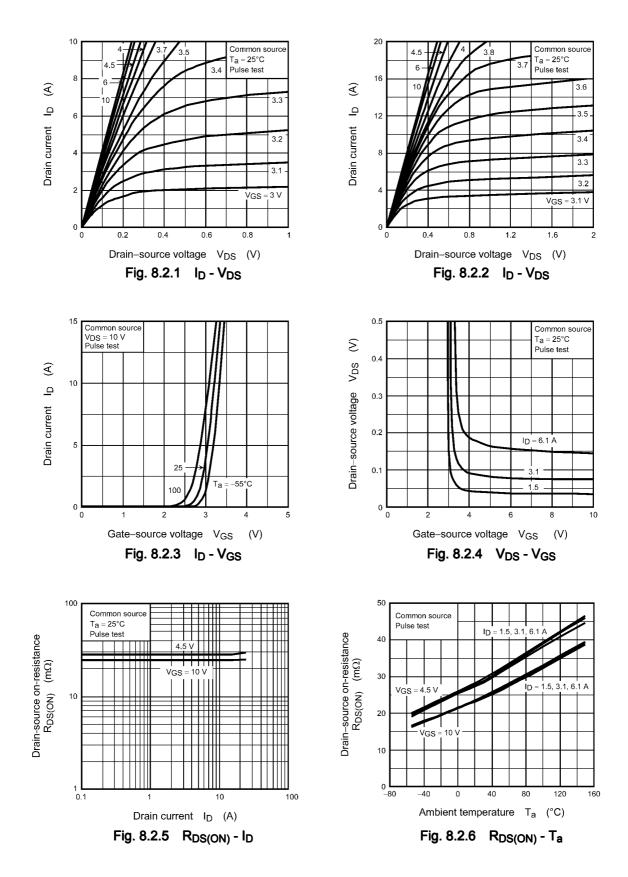


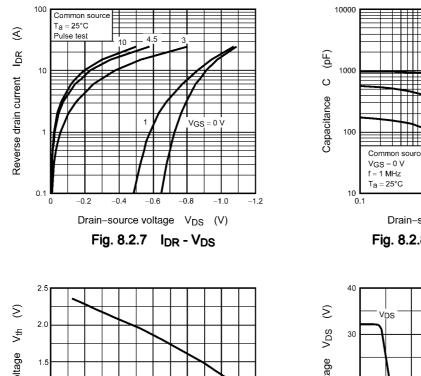
Drain-source voltage V<sub>DS</sub> (V) Fig. 8.1.13 Safe Operating Area (Guaranteed Maximum)

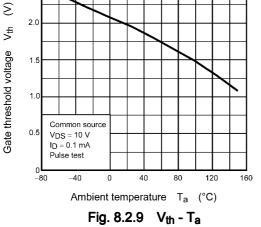
### TPC8408

## TOSHIBA

### 8.2. N-Channel MOSFET







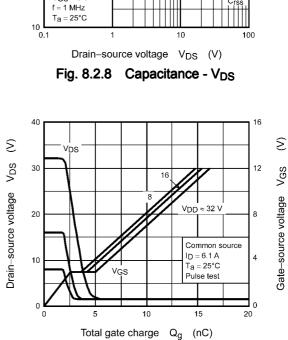
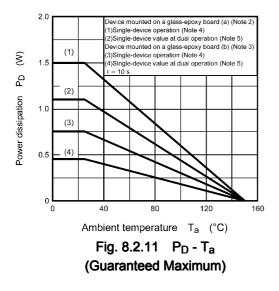
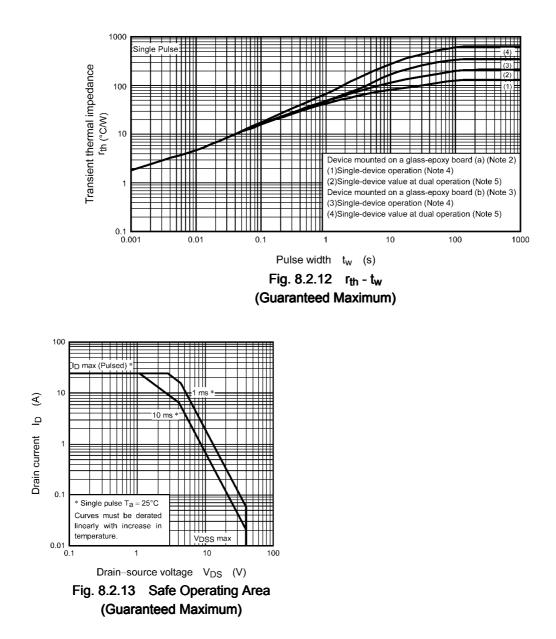


Fig. 8.2.10 Dynamic Input/Output Characteristics





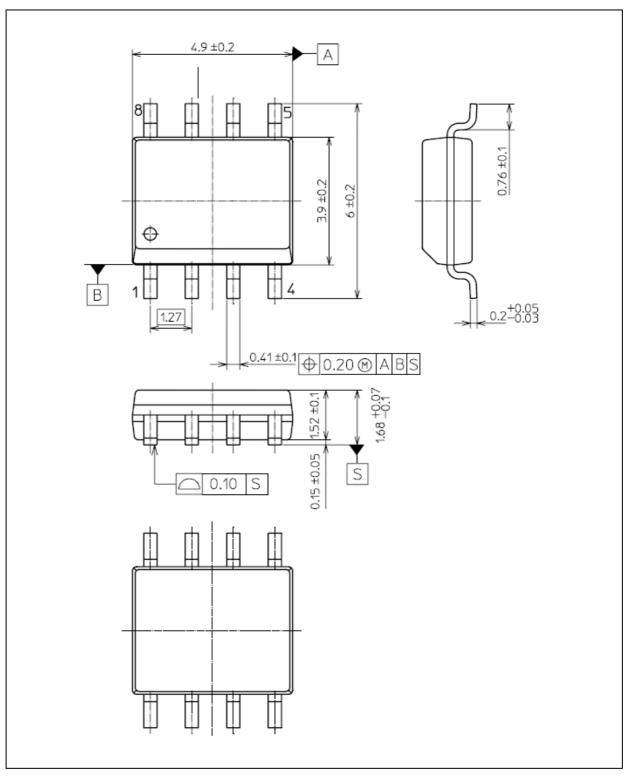
Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



#### Package Dimensions

TPC8408

Unit: mm



#### Weight: 0.085 g (typ.)

Package Name(s)

TOSHIBA: 2-5R1S

Nickname: SOP-8

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